TOSHIBA Field Effect Transistor Silicon P Channel MOS Type ($L^2-\pi$ -MOSV)

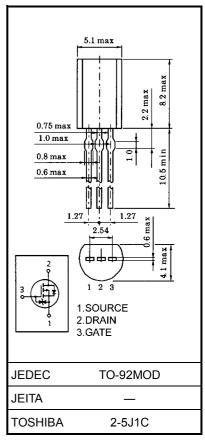
2SJ509

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- 4 V gate drive
- Low drain-source ON resistance $: R_{DS} (ON) = 1.35 \Omega (typ.)$
- High forward transfer admittance $: |Y_{fs}| = 0.7 \text{ S (typ.)}$
- Low leakage current $: I_{DSS} = -100 \ \mu A \ (max) \ (V_{DS} = -100 \ V)$
- Enhancement-mode : $V_{th} = -0.8 \sim -2.0 V (V_{DS} = -10 V, I_D = -1 mA)$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	-100	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	-100	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	-1	А	
	Pulse (Note 1)	I _{DP}	-3	А	
Drain power dissipation	n (Ta = 25°C)	PD	0.9	W	
Single pulse avalanche energy (Note 2)		E _{AS}	136.5	mJ	
Avalanche current		I _{AR}	-1	А	
Repetitive avalanche energy (Note 3)		E _{AR}	0.09	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 0.36 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient	R _{th (ch−a)}	138	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: $V_{DD} = -50 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 168 mH, $R_G = 25 \Omega$, $I_{AR} = -1 \text{ A}$

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution.

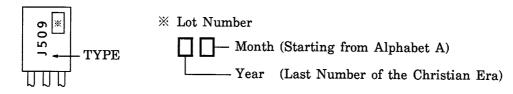
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V			±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -100 V, V _{GS} = 0 V			-100	μA
Drain−source br voltage	eakdown	V _{(BR) DSS}	I _D = -10 mA, V _{GS} = 0 V	-100	_	_	V
Gate threshold v	voltage	V _{th}	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ mA}$	-0.8	-	-2.0	V
Drain-source ON resistance		Pro (ou)	V_{GS} = -4 V, I _D = -0.5 A	_	1.68	2.5	Ω
		R _{DS (ON)}	V_{GS} = -10 V, I _D = -0.5 A	_	1.34	1.9	- 12
Forward transfer	r admittance	Y _{fs}	V_{DS} = -10 V, I _D = -0.5 A	0.3	0.7	_	S
Input capacitance	e	C _{iss}		_	135	_	
Reverse transfer capacitance		C _{rss}	V_{DS} = -10 V, V_{GS} = 0 V, f = 1 MHz	_	22	_	pF
Output capacitance		Coss			48	_	
Switching time	Rise time	tr	$V_{GS}_{-10V} \downarrow I_{D} = -0.5A$ V_{OUT} V_{UUT} $R_{L} = 100\Omega$ $V_{DD} = -50V$ $Duty \le 1\%, t_{W} = 10\mu s$	_	20	_	
	Turn-on time	t _{on}		_	32	_	
	Fall time	t _f		_	25	_	ns
	Turn-off time	t _{off}		_	130	_	
Total gate charge (Gate-source plus gate-drain)		Qg	V _{DD} ≈ −80 V, V _{GS} = −10 V,	_	6.3	_	
Gate-source charge		Q _{gs}	$I_D = -1 A$	—	4.1	—	nC
Gate-drain ("miller") charge		Q _{gd}		_	2.2	—	

Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—		_	-1	A
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-3	A
Forward voltage (diode)	V _{DSF}	I _{DR} = -1 A, V _{GS} = 0 V	_	_	1.5	V
Reverse recovery time	t _{rr}	I _{DR} = -1 A, V _{GS} = 0 V	_	90	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 50 A / μs	_	180	_	nC

Marking



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